Notice of References Cited

Application/Control No.
10/052,989
Examiner

Applicant(s)/Patent Under Reexamination HSIEH ET AL.

Examiner Art Unit
DAVID VU 2818

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,358,836	03-2002	Lu et al.	438/618
	В	US-6,348,399	02-2002	Lin, Chun Hung	438/616
	С	US-5,903,058	05-1999	Akram, Salman	257/778
	D	US-6,489,229 /	12-2002	Sheridan et al.	438/614
	Е	US-6,130,141 /	10-2000	Degani et al.	438/455
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*	NON-TATENT DOCUMENTS					
		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	w					
	х					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.